

Identification and Quantitation of Pesticides in the Parts-per-Trillion Range Using Retention Time Locking and GC/MS Application

Environmental, Food

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Abstract

The typical pesticide quantitation limit for a mass spectrometer in the Scan mode is in the sub-ppm range. By using a selected ion monitoring method, a lab can lower the target compound quantitation limit to the low parts-per-billion ($pg/\mu L$) range using a retention time locked gas chromatography/mass spectrometry method. By adding large volume injection capability to the method, target compounds at parts-per-trillion can be quantified.

A specially developed 567-compound retention time locking pesticide mass spectral library can automatically screen an acquired sample's data file for all 567 compounds in seconds. The library can also be applied for rapid screening of samples acquired in selected ion monitoring method. Using the compound library information, a selected ion monitoring method for 80 target compounds was created in less than 2 hours without running any analyses.

Introduction

Most pesticides are typically analyzed on a gas chromatograph (GC) with element-selective detectors (ESDs). Although these ESDs provide low ppb detection limits and are easy to operate, the data do not provide sufficient information to confirm a compound's presence with confidence. Due to the universal nature of mass spectrometric detection, a mass spectrometer (MS) provides additional information and increased confidence in the assignment of compound identity. With recent advances in GC/MS hardware and software and the decrease in cost of ownership, more and more laboratories are routinely analyzing pesticide residue samples with MS detection.

To match the GC/ESD detection limits and/or to eliminate sample concentration steps, a user must lower the MS detection limit by 2 to 3 orders of magnitude. This application note, discusses the following approaches.

- Run the MS in single ion monitoring (SIM) mode
- Make large volume injections (LVIs)
- Use higher electron multiplier voltage (EMV)

For compound identification, a specially developed 567-compound retention time locking (RTL) [1] pesticide library could perform the entire 567-compound screening in seconds using Scan data. A subset of the library could be screened in seconds from SIM data.

Experimental

A pesticide standard mixture was used to compare the lowest detection limits of splitless injection and LVI under Scan and SIM modes.



System Configuration for Screening and Quantitation:

- 6890 GC with a programmable temperature vaporizer (PTV) [2,3] inlet
- 5973 Mass Selective Detector (MSD)
- 7683 Automatic Liquid Sampler (ALS) tray and autoinjector
- + HP-5MS capillary column (30 m \times 0.25 mm \times 0.25 μm), P/N 19091S-433
- G1701BA version B.00.00 MSD ChemStation software or higher
- G1049A MSD RTL Pesticide Database/Library

Table 1. GC Method Parameters

| Oven | 70(2)/25/150(0)/3/200(0)/8/280(10) = 41.87 min |
|----------------|---|
| Inlet | PTV |
| Inlet pressure | 17.30 psi (locked to methyl chlorpyrifos at 16.593 min), constant pressure mode |

Table 2. Injection Parameters

| Injection mode | Solvent vent | Splitless |
|----------------------------------|--|--|
| Injection volume (syringe) | 25 µL (50-µL syringe, Р/N 5183-0318) | 1 µL (10-µL syringe, Р/N 9301-0713) |
| Injection speed | Inject @ 100 µL/min Draw @ 300 µL/min Dispense @ 4500 µL/min | Fast |
| Inlet temp | 40(0.35)/600/320 (3)/50/200 (Hold until end) | 280 °C |
| Vent | Vent time = 0.29 min Vent flow = 150 mL/min Vent pressure = 0.00 psi | |
| Purge | 60 mL/min @ 2 min | 60 mL/min @ 2 min |
| Liner | Deactivated, Multi Baffled (P/N 5183-2037) | Deactivated, Multi Baffled (P/N 5183-2037) |
| Inlet cooling | Liquid CO ₂ | None |

Table 3.MS Method Parameters

| Solvent delay | 3 min |
|---------------------|------------------------------|
| Tune file | Atune.u |
| Transfer line | 280 °C |
| MS Quad | 150 °C |
| MS source | 230 °C |
| Threshold | 150 |
| Sample # | 2 |
| Scan range | 35 to 500 amu (in Scan mode) |
| Forty (40) SIM grou | ps (in SIM mode) |
| | |

| Tahle 4 | Pesticide Screening | Parameters for the SIM Method |
|-----------|---------------------|-------------------------------|
| 1 auic 4. | | |

| Extraction window | ±0.100 minute | | |
|-------------------|--------------------|--|--|
| Qualifier mode | Absolute | | |
| Qualifier % | 30 | | |
| Zero qualifiers | Included | | |
| Subtraction mode | Average start/stop | | |
| Screen database | Rtlpest.SCD | | |

Results and Discussion

RTL [1] was used to:

- 1. Expedite data comparison in overlay format
- 2. Achieve lower target compound detection limit
- 3. Allow rapid pesticide screening using the RTL pesticide database/library
- 4. Help to differentiate isomers by their retention time (RT) differences
- 5. Eliminate the tedious SIM method RT updating process after column maintenance
- 6. Simplify the editing of the SIM ion groups

A mixture from the California Department of Food and Agriculture (CDFA) of 80 pesticides at 5000 pg/ μ L each was used as the stock solution for this study. The mixture contained carbamate, organochlorine, organophosphorus, and organonitrogen pesticides. Figure 1 is an offset overlay of three total ion chromatograms (TIC) with 50, 100, and 500 pg of each of the pesticides injected. These TICs were obtained in the Scan mode from 1- μ L spiltless injections. For many of these pesticides the quantitation limit in the Scan mode is about 500 pg on column.

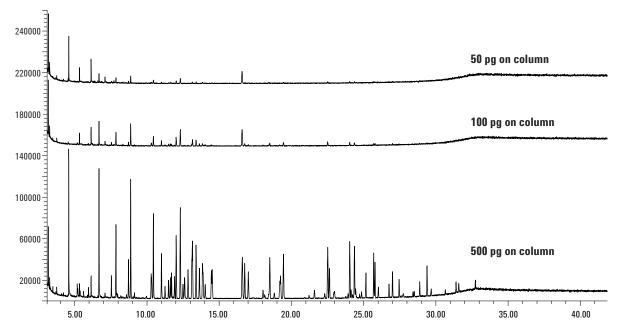


Figure 1. Total ion chromatograms from 1-μL splitless injections of 80 pesticides with 50, 100, and 500 pg of each compound injected.

SIM Mode

To lower the detection limit, a SIM method was created. Instead of the traditional way of making a SIM method, a user can use the information in the RTL Pesticide Database to build a SIM method without running an analysis. Here are the steps for editing SIM ion group parameters:

1. List the MSD RTL Pesticide Database from the ChemStation (Figure 2 is a partial listing) and paste the complete listing into a spreadsheet.

| Scdlist.txt - Notepad File Edit Search Help | | | | | | |
|--|----------|--------------|------------|-----------|----------------|---|
| SCD Compound | List P | leport | | | | - |
| Screen Database : C:\DATABASE Total SCD Cpnds : 567 | NRTLPES | ST . SCD | | | | _ |
| Cpd# Compound Name | TIon | E×p_RT | Q1 | Q2 | Q3 | |
| 1 Diethylene glycol | 45 | 3.39 | 75 | 76 | 44 | |
| 2 Aniline | 93 | 3.55 | 66 | 65 | 92 | |
| 3 p-Dichlorobenzene | 146 | 3.88 | 148 | 111 67 | 92 75 65 | |
| 4 Dicyclopentadiene 5 Dimefox | 66 44 | 4.00 4.01 | 132 110 | 154 | 42 | |
| 6 o-Dichlorobenzene | 146 | 4.09 | 148 | 111 | 75 | |
| 7 2-Methylphenol | 108 | 4.25 | 107 | 77 | 79 | |
| 8 4-Methylphenol | 107 | 4.42 | 108 | 77 | 79 | |
| 9 m-Cresol | 108 | 4.42 | 107 | 79 | 77 | |
| 10 1,2-Dibromo-3-chloropropane | 157 | 4.53 | 155 | 75 | 159 | |
| 11 2,4-Dimethylaniline | 121 | 5.19 | 120 | 106 | 77 | |
| 12 2,6-Dimethylaniline | 121 | 5.20 | 106 | 120 | 77 | |
| 13 2,4-Dichlorophenol | 162 | 5.19 | 164 | 63 | 98 | |
| 14 1,2,4-Trichlorobenzene | 180 | 5.29 | 182 | 184 | 145 | |
| 15 Ethiolate | 100 | 5.41 | 72 | 161 | 44 | |
| 16 3-Chloroaniline | 127 | 5.45 | 129 | 65 | 92 | |
| 17 4-Chloroaniline | 127 | 5.48 | 129 | 65 | 92 | |
| 18 2-Ethyl-1,3-hexanediol | 56 | 5.51 | 55 | 73 | 57 | |
| 19 p-Nitrotoluene | 91 | 5.57 | 137 | 65 | 107 | |
| 20 Methamidophos | 94 | 5.66 | 95 | 141 | 47 | |
| 21 Dichlorvos | 109 | 5.83 | 185 | 79 | 187 | |
| 22 Allidochlor | 41 | 6.18 | 56 | 138 | 132 | |
| 23 2,3,5-Trichlorophenol | 196 | 6.63 | 198 | 200 | 160 | |
| 24 2,6-Dichlorobenzonitrile | 171 | 6.75 | 173 | 136 | 100 | |
| T | | | | | | ► |

Figure 2. A partial listing of the pesticide screener database. The listing includes the compound number, compound name, target ion, expected retention time, and three qualifier ions.

- 2. In the spreadsheet, delete the rows of the compounds not needed in the method.
- 3. Separate target compounds into groups (see the added "Group #" column on Figure 3) using these criteria:
 - One to three compounds in each group, and
 - The RTs of the adjacent compounds in adjacent groups are at least 0.2 minute apart. For example, compounds 42 and 51 are more than 0.2 minute apart, so they are in different groups. Compounds 51 and 55 are less than 0.2 minute apart, so they are in the same group.
- 4. Use the average RT of the adjacent compounds in adjacent groups as the SIM group RT (see the added "Group RT" column on Figure 3). For example, the average retention time of compound 42 (7.91 min, in group 2) and compound 51 (8.78 min, in group 3) is 8.35 minute which is used as the starting retention time of group 3. When all the group numbers and respective starting retention times are determined, make a hardcopy of the spreadsheet for easy entry into the "MS SIM/Scan Parameters" in the next step.
- 5. Enter the target ion and qualifier ion(s) (Q1, Q2, and/or Q3) of all compounds into the respective ChemStation SIM group (Figure 4). Notice that all the information for building the SIM groups came from Figure 3.

| # | Compound Name | MSD RT | T | 01 | Group # | Group RT |
|-----|--------------------------|--------|-----|-----|---------|----------|
| 24 | 2.6-Dichlorobenzonitrile | 6.75 | 171 | 173 | 1 | 3.00 |
| 35 | Mevinphos | 7.60 | 127 | 192 | | |
| 42 | Propham | 7.91 | 93 | 179 | 2 | 7.75 |
| 51 | o-Phenylphenol | 8.78 | 170 | 169 | 3 | 8.35 |
| 55 | Pentachlorobenzene | 8.95 | 250 | 252 | | |
| 76 | Propoxur | 10.35 | 110 | 152 | 4 | 9.60 |
| 82 | Diphenylamine | 10.52 | 169 | 168 | | |
| 92 | Chlorpropham | 11.05 | 127 | 213 | 5 | 10.76 |
| 98 | Ethalfluralin | 11.28 | 276 | 316 | | |
| 102 | Bendiocarb | 11.54 | 151 | 126 | 6 | 11.41 |
| 103 | Trifluralin | 11.64 | 306 | 264 | | |
| 104 | Benfluralin | 11.73 | 292 | 264 | | |
| 111 | Phorate | 11.96 | 75 | 121 | 7 | |
| 113 | BHC alpha isomer | 12.09 | 181 | 219 | | |
| 117 | Hexachlorobenzene | 12.38 | 284 | 286 | | |
| 120 | Dicloran | 12.56 | 206 | 176 | | |
| 122 | Demeton-S | 12.63 | 88 | 60 | | |
| 124 | Dimethoate | 12.68 | 87 | 93 | | |
| 129 | Simazine | 12.91 | 201 | 186 | | |

Figure 3. A spreadsheet of target compounds separated into different SIM groups with RTs of the adjacent compounds in adjacent groups at least 0.2 minute apart. The starting retention time of each group was determined by calculating the average RT of the adjacent compounds in adjacent groups. The number of qualifier ions used in a SIM method depends on the number of analytes of interest. For a method monitoring 20 to 30 compounds, all three qualifier ions should be used in the SIM method. As the list of target compounds grows, fewer qualifier ions should be used in the method to maintain a reasonable and comparable ion dwell time and sampling rate.

In general, 10 scans (cycles) per peak are recommended for quantitation purposes. For example, if an analyte peak is 6 seconds wide, about 1.7 cycles per second should be maintained for that SIM ion group. Once the number of cycles per second is determined, the dwell time of the ions can be varied to meet that. As the dwell time is entered for each ion, the ChemStation automatically shows the number of cycles per second. In Figure 4, Group 6 has 3.03 cycles per second.

| MS In: | /Scan Parameters strument Paramete mple Inlet: GC | | | 1 | Time Plot Time <u>W</u> ind Window <u>1</u> | | min. | X |
|--------|--|------------|-----------------|-----|--|-------|----------|------|
| | Tune File: ATUNE M <u>V</u> oltage: 0 vent Delay: 3.00 | E.U Rel | • = 1200 | -MS | ot Type: 1 Y-Scale: 0 Window <u>2</u> ot Type: 1 | 2 | to 25000 | |
| | cq. Mode: SIM | | • | | Y-Scale: 0 | | to 64000 | 00 |
| MS SI | M Parameters Group ID | Time I | Besolution | | m/z | Dwell | Plot | |
| 4 | | 9.60 | Low | > | | 50 | Window 1 | te l |
| 5 | 5 | 10.76 | Low | 2 | 151.00 | 50 | | |
| -> | 6 | 11.41 | Low | 3 | 264.00 | 50 | | |
| 7 | 7 | 11.84 | Low | 4 | 292.00 | 50 | | - |
| | Delete Group | Cycles/se | ec = 3.03 | | Delete | on | | |
| | Events Zor | | | | OK | | ancel | Help |

Figure 4. A screen capture of the MSD ChemStation showing the MS and SIM parameters. The SIM parameters (group ID, group retention time, and ions) were all derived from Figure 3.

Figure 5 shows two chromatograms obtained from $1-\mu L$ splitless injections at 50 pg/ μL using both Scan and SIM modes. The Scan mode has significantly higher baseline noise than the SIM mode. Some of the compounds, especially the late eluters, were not detected in the Scan mode. When the Scan method was changed to a SIM method at this concentration, the signal-to-noise ratio (S/N) increased by a factor of 100. It is worth pointing out that a SIM method does not record background ions from the sample matrix, therefore minimizing the baseline noise and improving the S/N.

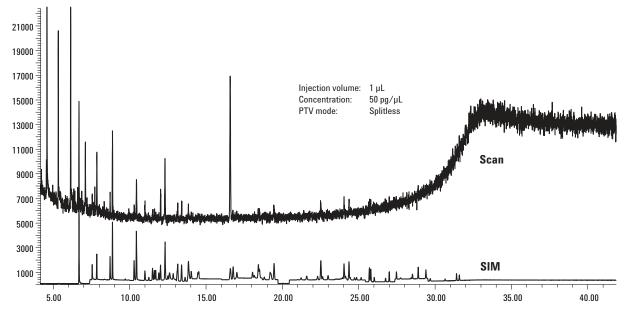


Figure 5. Chromatograms of 1- μ L splitless injections at 50 pg/ μ L from Scan and SIM modes.

In a SIM method, the retention times of the ion groups normally need updating after column maintenance. By using RTL, a user can not only eliminate the tedious RT updating process [4] but also decrease the detection limit. With reproducible known RTs of target compounds, the start and end time of each ion group can be determined optimally. By narrowing the time windows of an ion group to monitor only one or two compounds at a time, the MS can monitor fewer ions in each window, allowing more sampling time for the target ions.

Ideally, a SIM method will have the maximum number of ion groups and the minimum number of ions in each group. In this way, each ion group can get more scans per unit time resulting in better peak shape and more accurate quantitation.

LVIs

To decrease the detection limit further, a user can put more sample on column using the LVI technique. The typical "solvent-vent" approach is to inject the sample slowly into a PTV inlet at a temperature just below the solvent boiling point and let solvent evaporate before ramping up the inlet temperature to move the compounds onto the capillary column. Figure 6 compares a 1-µL splitless injection with a 25-µL solvent-vent injection. Both injections resulted in 50 pg per compound on column. Note that the solvent-vent ion chromatogram is plotted upside down for ease of comparison with the splitless ion chromatogram. It is obvious from the figure that the two techniques provide very similar results. This demonstrates that the solvent-vent technique is a viable approach for sample introduction.

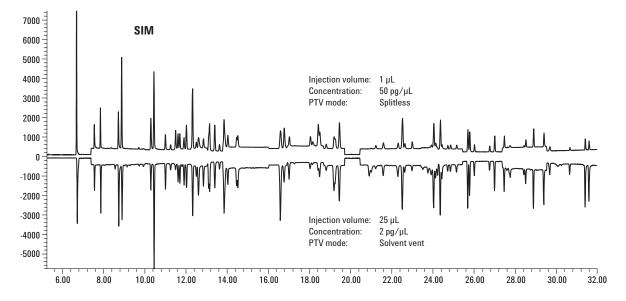


Figure 6. SIM results of 50 pg on column using either a 1-µL splitless or a 25-µL solvent-vent injection.

Higher EMV

It is known that the signal increases with higher EMV on the MS. In Figure 7, the upper signal, after 10-fold magnification, is a 25-µL LVI of 0.5 pg/µL at tune voltage. The bottom signal is the same injection with the electron multiplier set to tune +400 V. Adding 400 V to the EMV increases

the signal by 10X, which makes the integration more accurate. However, the baseline noise also increases by 10X, so the S/N stays the same.

Although increasing the EMV does help to bring small peaks over the detection threshold, it shortens the life of the multiplier. In general, the EMV should be kept at the tune voltage.

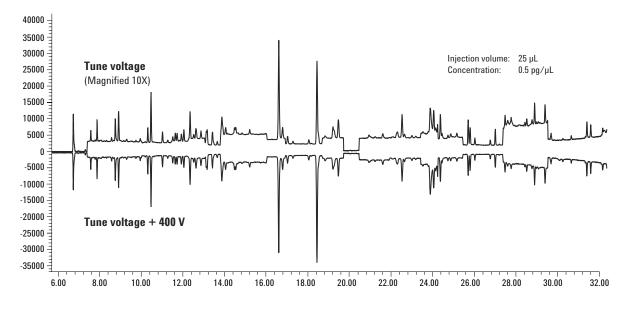


Figure 7. SIM results of 12.5 pg on column using either EMV at Tune voltage or Tune +400 V.

LVIs in Combination with SIM Methods

Combining LVI and SIM, Figures 8 and 9 show quantifiable peaks of three compounds at as low as 5 pg on column. In Figure 8, ion chromatograms of endosulfan sulfate and p,p'-DDT at 0.2 and 500 pg/ μ L are shown. The top chromatogram was from a 25- μ L solvent-vent SIM method and the bottom chromatogram was from a 1- μ L splitless Scan method. By using LVI and SIM, it is interesting to see that similar S/N ratios were achieved even with a 2500-fold decrease (from 500 to $0.2 \text{ pg/}\mu\text{L}$) in sample concentration.

By increasing the injection volume to $100 \ \mu$ L, samples at concentration as low as $0.05 \ \text{pg/}\mu$ L can also be quantified as shown in Figure 9. The top portion shows the chlorthal-dimethyl extracted ion chromatograms (EIC) of mass 299 and 301 from a $100-\mu$ L full Scan run. The bottom portion shows the same ions from a $100-\mu$ L SIM run. The SIM method shows better peak shape and lower baseline noise.

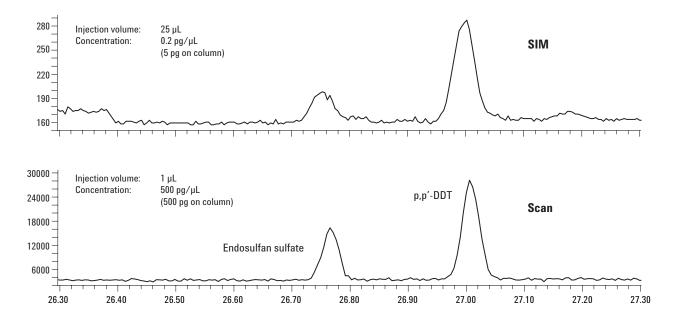


Figure 8. Ion chromatograms of endosulfan sulfate and p,p'-DDT at 0.2 and 500 pg/ μ L. The top chromatogram was from a 25- μ L solvent-vent SIM method and the bottom chromatogram was from a 1- μ L splitless Scan method.

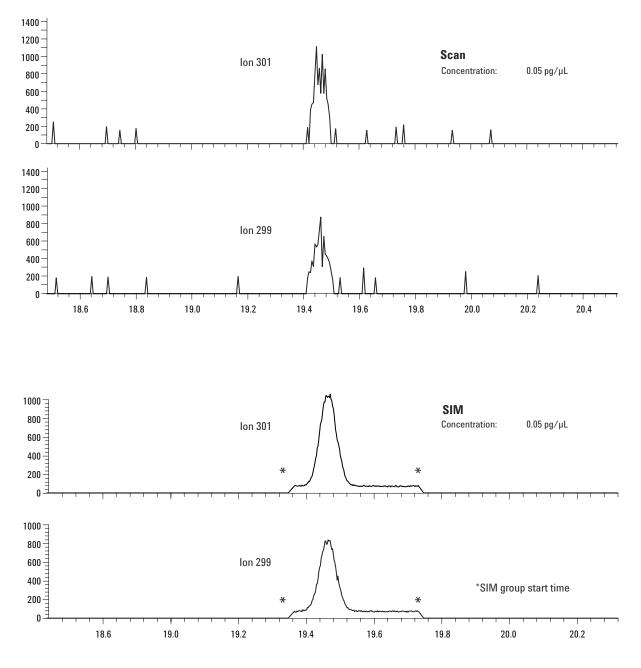


Figure 9. Ion chromatograms of 100- μ L chlorthal-dimethyl injected at 0.05 pg/ μ L. The top portion was from a full Scan run and the bottom portion was from a SIM run.

Target Compound Screening

Combing RTL and the G1049A MSD RTL Pesticide Database/Library, a user can screen for 567 pesticides and suspected endocrine disrupters from any Scan run [5]. A user can screen a subset of the library with improved sensitivity using a SIM method. The MSD ChemStation can generate a 567-compound screening report automatically in less than 30 seconds. Figure 10 is a report of the 0.5 pg/ μ L sample (25 μ L injected in SIM mode) that lists the "probable hits" (marked with an x) and "possible hits" (marked with a ?). All target compounds at this 12.5 pg on column level were found by the software.

| Eile Edit Search Window X Screen Report (Not Reviewed) X |
|--|
| |
| Data File : C:\SYS_X\DATA\80MIX\0403SIM\0_5PG2.D Vial: 16 Acq On : 3 Apr 2001 10:26 Operator: 40 SIMgrps,40gr Sample : CDFA 80 mix 10000:1 Inst : GC/MS Ins Misc : CDFA 80 mix = 5 ng/µL Multiplr: 1.00 Sample Amount: 0.00 |
| MS Integration Params: events.e |
| Screen File: Rtlpest.RES Screen Database: Rtlpest.SCD Qualifier Mode : Absolute Qualifier % : 30 Zero qualifiers : Included Subtraction Mode : Sub Average Start/Stc_ |
| Target Qualifiers Compound Status ExpRT Delta m/z Resp. Out of Range XCR |
| 16 3-Chloroaniline ? 5.453 +0.034 127 11386 129 0.92 17 4-Chloroaniline ? 5.478 +0.009 127 17984 129 0.92 24 2.6-Dichlorobenzonitril * 6.752 -0.031 171 171652 0.97 35 Mevinphos * 7.595 -0.035 127 101291 0.96 42 Propham ? 7.908 -0.039 93 107866 119,137 0.76 51 o-Phenylphenol ? 8.947 -0.048 250 121353 248 0.85 76 Propoxur * 10.353 -0.050 110 212997 0.99 82 Diphenylamine * 10.516 -0.034 127 81328 153,154 0.75 102 Bendiocarb ? 11.045 -0.034 127 81328 153,154 0.75 103 Trifluralin * 11.637 -0.011 306 41880 0.93 104 Benfluralin * 11.962 -0.042 75 63143 121,260 0.88 113 BHC alpha isomer ? 12.084 -0.045 181 46666 219,183,217 0.60 1 117 Hexachlorobenzene ? 12.377 |

Figure 10. Typical report from the GC/MS pesticide screener showing probable "hits" (marked with an x) and possible hits (marked with a ?). Other information includes the library retention time followed by the RT difference in this chromatogram, the target ion, its abundance, out of range qualifier(s), and a cross correlation value with the library spectrum.

Conclusions

Using the information (compound names, retention times, and ion masses) in the RTL pesticide database, a SIM method of 80 target compounds can be created in less than 2 hours without running any analyses. The examples show that both LVI and SIM are effective techniques to decrease the quantitation limit of target compounds from sub-ppm to ppt.

Any lab can decrease the quantitation limit by a factor of 100 without any hardware modification. Lowering the quantitation limit from 500 pg down to 5 pg on column can be done using a SIM method and RTL. By adding LVI to the system, target compounds in femtogram/ μ L can be quantified.

Acknowledgement

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